Computer Memory Test Labs

Intel® Advanced Tested Final Report

Manufacturer Name: Ventura Technology Group
Manufacturer Part #: D4-62JA402SV-15
Module Size: 16GB
Module Config: 2048M x 72
DRAM Manufacturer: Samsung
DRAM Part #: K4A4G045WD-BCPB rev D
PCB Part #: M393A2G40DB0-V05
PCB Layer Count: 12 Layer
Module Info: Registered 1.2V
Assembly: JEDEC Standard/Non-stacked
Register Part: 4RCD0124KC0-ATG
Environment Code: RoHS - H
Low Profile: 30 mm LP
Bank: 2
Dual Die Package Support

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CMTL Part #: VEN272

MINIMUM SYSTEM INFORMATION

Minimum System: S2600WT
Serial Number: BQWS42490408
Bios at time of test: SE5C610.86B.01.01.0627
Processor Code: Intel® Xeon® E5-2637 v3 @ 3.50GHz
Memory Count: 128GB
Event Log Verify: Clear
OS Memory Count: 128GB
OS/Service Pack: Windows 2012 Enterprise Edition 64 R2
Software Pack: IWVSS 2.5.3 2.10.1.0073
Disk Manuf: OCZ-SSD 60GB

MAXIMUM SYSTEM INFORMATION

Maximum System: S2600WT
Serial Number: BQWS42490412
Bios at time of test: SE5C610.86B.01.01.0627
Processor Code: Intel® Xeon® E5-2637 v3 @ 3.50GHz
Memory Count: 384GB
Event Log Verify: Clear
OS Memory Count: 384GB
OS/Service Pack: Windows 2012 Enterprise Edition 64 R2
Software Pack: IWVSS 2.5.3 2.10.1.0073
Disk Manuf: OCZ-SSD 60GB

PRE-TESTING INFORMATION

Board Revision: H40442-001
Insertion Test: Pass
SPD Check: Pass
Speed Check: Pass
Power Cycle: Pass
Power Cycle Time: 100

Voltage Margining Info
Volt % VPP2.5 & VDDQ1.2
Volt Low 2.42v & 1.1v
Volt High 2.64v & 1.22v

TESTING DETAILS [- Side]

Temperature: 40°C
Time: 12Hr
Start Date: 9/30/14
Stop Date: 10/7/14
Min IWVSS Test Status: Pass
Max IWVSS Test Status: Pass
SEL Min: Pass
SEL Max: Pass
Summary Min: Pass
Summary Max: Pass
Test Phase Status: Pass

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Summary Min: Pass
Summary Max: Pass
Test Phase Status: Pass

Test Notes:
Min configuration memory speed ran @ 2133MHz
Mid configuration memory speed ran @ 1866MHz, memory count 256GB
Max configuration memory speed ran @ 1600MHz